TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT Process)

2SC4935

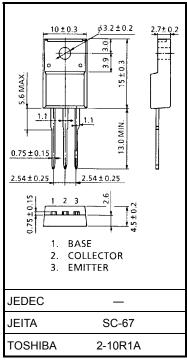
Power Amplifier Applications

Unit: mm

- Good hfe linearity
- Complementary to 2SA1869 and 5-watt-output applications.

Maximum Ratings (Tc = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V_{CBO}	50	V	
Collector-emitter voltage		V _{CEO}	50	V	
Emitter-base voltage		V _{EBO}	5	V	
Collector current		Ic	3	Α	
Base current		Ι _Β	0.3	Α	
Collector power dissipation	Ta = 25°C	Pc	2.0	W	
	Tc = 25°C		10		
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	-55 to 150	°C	



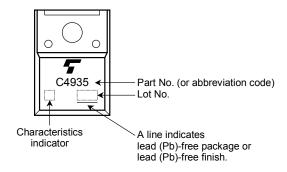
Weight: 1.7 g (typ.)

Electrical Characteristics (Tc = 25°C)

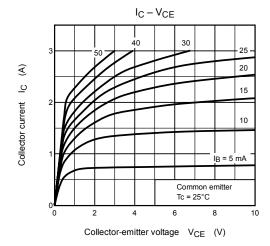
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	V _{CB} = 50 V, I _E = 0	_	_	1.0	μΑ
Emitter cut-off current	I _{EBO}	V _{EB} = 5 V, I _C = 0	_	_	1.0	μA
Collector-emitter breakdown voltage	V (BR) CEO	I _C = 10 mA, I _B = 0	50	_	_	V
DC current gain	h _{FE (1)} (Note)	V _{CE} = 2 V, I _C = 0.5 A	70	_	240	
	h _{FE (2)}	V _{CE} = 2 V, I _C = 2.5 A	30	_	_	
Collector-emitter saturation voltage	V _{CE (sat)}	I _C = 2 A, I _B = 0.2 A	_	0.4	0.6	V
Base-emitter voltage	V _{BE}	V _{CE} = 2 V, I _C = 0.5 A	_	0.75	1.0	V
Transition frequency	f _T	V _{CE} = 2 V, I _C = 0.5 A	_	80	_	MHz
Collector output capacitance	C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1 MHz	_	30	_	pF

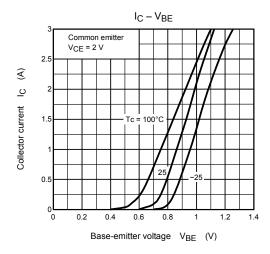
Note: hFE (1) classification O: 70 to 140, Y: 120 to 240

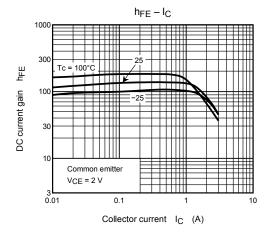
Marking

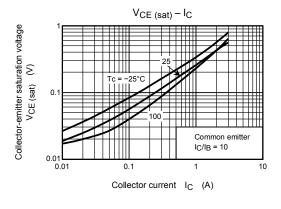


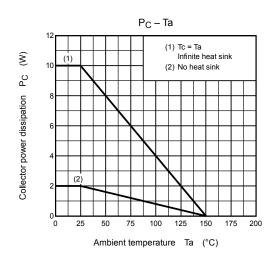
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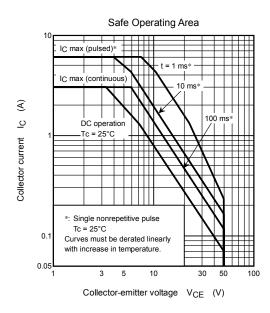












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